

Data Sheet	January 2002	

8A, 1200V Ultrafast Diode

The RURP8120 is an ultrafast diode with soft recovery characteristics (t_{rr} < 100ns). It has low forward voltage drop and is of silicon nitride passivated ion-implanted epitaxial planar construction.

This device is intended for use as a freewheeling/clamping diode and rectifier in a variety of switching power supplies and other power switching applications. Its low stored charge and ultrafast soft recovery minimize ringing and electrical noise in many power switching circuits, thus reducing power loss in the switching transistors.

Formerly developmental type TA49095.

Ordering Information

PART NUMBER	PACKAGE	BRAND
RURP8120	TO-220AC	RURP8120

NOTE: When ordering, use the entire part number.

Symbol



Features

• Operating Temperature175 ^o
• Reverse Voltage

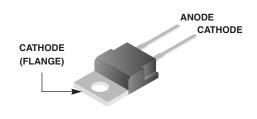
- · Avalanche Energy Rated
- Planar Construction

Applications

- · Switching Power Supplies
- · Power Switching Circuits
- · General Purpose

Packaging

JEDEC TO-220AC



Absolute Maximum Ratings T_C = 25°C, Unless Otherwise Specified **RURP8120** UNITS 1200 Working Peak Reverse VoltageV_{RWM} 1200 DC Blocking VoltageV_R 1200 8 $(T_C = 144^{\circ}C)$ 16 (Square Wave, 20kHz) 100 (Halfwave, 1 Phase, 60Hz) 75 W Avalanche Energy (See Figure 10 and Figure 11)......E_{AVI} 20 m.J οС -65 to 175

Electrical Specifications $T_C = 25^{\circ}C$, Unless Otherwise Specified

SYMBOL	TEST CONDITION	MIN	TYP	MAX	UNITS
V _F	I _F = 8A	-	-	2.1	V
	I _F = 8A, T _C = 150°C	-	-	1.9	V
I _R	V _R = 1200V	-	-	100	μΑ
	V _R = 1200V, T _C = 150°C	-	-	500	μΑ
t _{rr}	$I_F = 1A$, $dI_F/dt = 100A/\mu s$	-	-	100	ns
	$I_F = 8A$, $dI_F/dt = 100A/\mu s$	-	-	110	ns
t _a	$I_F = 8A$, $dI_F/dt = 100A/\mu s$	-	60	-	ns
t _b	$I_F = 8A$, $dI_F/dt = 100A/\mu s$	-	40	-	ns
Q _{RR}	$I_F = 8A$, $dI_F/dt = 100A/\mu s$	-	380	-	nC
СЈ	V _R = 10V, I _F = 0A	-	25	-	pF
R _{θJC}		-	-	2	°C/W

DEFINITIONS

 V_F = Instantaneous forward voltage (pw = 300 μ s, D = 2%).

I_R = Instantaneous reverse current.

 t_{rr} = Reverse recovery time (See Figure 9), summation of $t_a + t_b$.

 t_a = Time to reach peak reverse current (See Figure 9).

 t_b = Time from peak I_{RM} to projected zero crossing of I_{RM} based on a straight line from peak I_{RM} through 25% of I_{RM} (See Figure 9).

 $R_{\theta JC}$ = Thermal resistance junction to case.

 Q_{RR} = Reverse Recovery Charge.

C_J = Junction Capacitance.

pw = pulse width.

D = duty cycle.

Typical Performance Curves

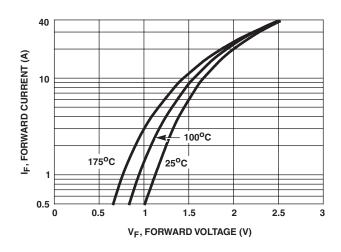


FIGURE 1. FORWARD CURRENT vs FORWARD VOLTAGE

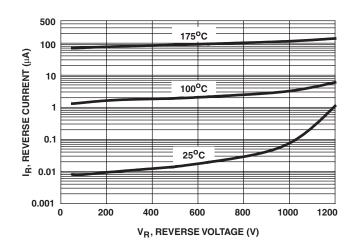


FIGURE 2. REVERSE CURRENT vs REVERSE VOLTAGE

Typical Performance Curves (Continued)

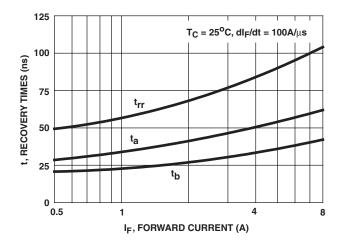


FIGURE 3. t_{rr}, t_a AND t_b CURVES vs FORWARD CURRENT

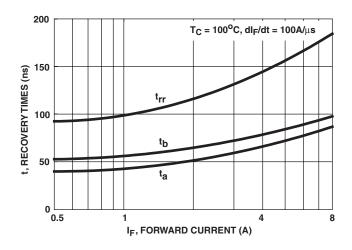


FIGURE 4. t_{rr} , t_a and t_b curves vs forward current

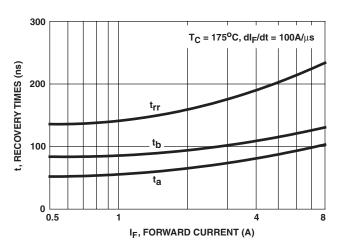


FIGURE 5. t_{rr}, t_a AND t_b CURVES vs FORWARD CURRENT

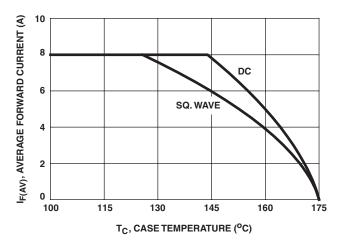


FIGURE 6. CURRENT DERATING CURVE

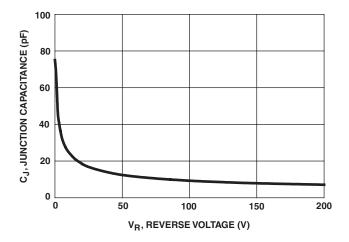


FIGURE 7. JUNCTION CAPACITANCE vs REVERSE VOLTAGE

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Test Circuits and Waveforms

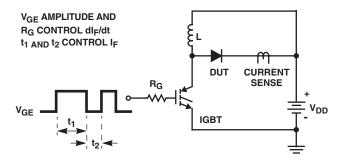


FIGURE 8. t_{rr} TEST CIRCUIT

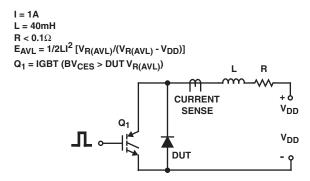


FIGURE 10. AVALANCHE ENERGY TEST CIRCUIT

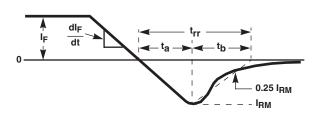


FIGURE 9. t_{rr} WAVEFORMS AND DEFINITIONS

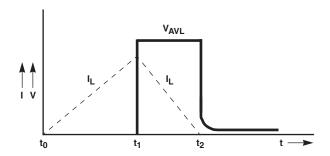


FIGURE 11. AVALANCHE CURRENT AND VOLTAGE WAVEFORMS

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Definition of Terms

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